Search Notes

Application/Control No.	Applicant(s)/Patent under Examination	
10/680,578	LEE ET AL.	
Examiner	**Art Unit**	
Vikki H. Trinh	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	622, 751, 773, 775, 776	1/20/2005	VT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR